



H45N03E

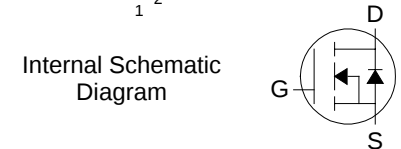
N-Channel Enhancement-Mode MOSFET (25V, 45A)

Features

- $R_{DS(on)}=15m\Omega@V_{GS}=10V, I_D=25A$
- $R_{DS(on)}=20m\Omega@V_{GS}=4.5V, I_D=25A$
- Advanced trench process technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for DC/DC Converters and Motor Drivers
- Fully Characterized Avalanche Voltage and Current
- Improved Shoot-Through FOM

H45N03E Pin Assignment

3-Lead Plastic **TO-220AB**
Package Code: E
Pin 1: Gate
Pin 2 & Tab: Drain
Pin 3: Source



Maximum Ratings & Thermal Characteristics

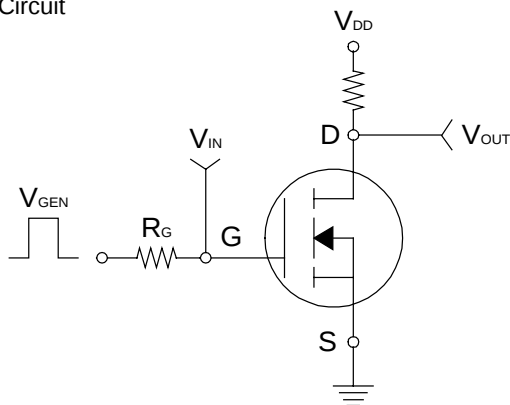
($T_A=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Value	Units
Drain-Source Voltage	V_{DS}	25	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	45	A
Pulsed Drain Current ^{*1}	I_{DM}	180	A
Maximum Power Dissipation @ $T_C=25^{\circ}C$	P_D	60	W
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 150	$^{\circ}C$
Avalanche Energy with Single Pulse $I_D=35A, V_{DD}=20V, L=0.14mH$	E_{AS}	300	mJ
Junction-to-Case Thermal Resistance	$R_{\theta JC}$	2.1	$^{\circ}C/W$
Junction-to-Ambient Thermal Resistance(PCB mounted) ^{*2}	$R_{\theta JA}$	55	$^{\circ}C/W$

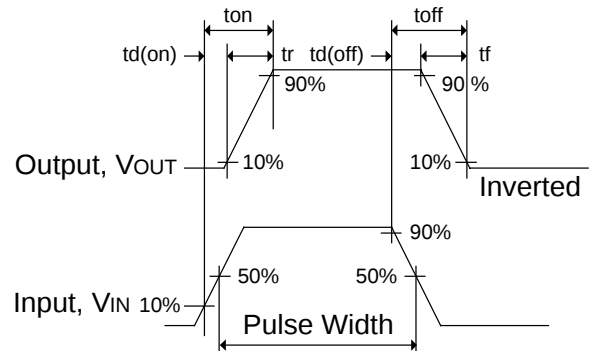
*1: Maximum DC current limited by the package.

*2: 1-in² 2oz Cu PCB board

Switching Test Circuit



Switching Waveforms





Electrical Characteristics

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	25	-	-	V
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} =4.5V, I _D =25A	-	-	20	mΩ
		V _{GS} =10V, I _D =25A	-	-	15	
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250uA	1	1.6	3	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =24V, V _{GS} =0V	-	-	1	uA
Gate Body Leakage	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
Gate Resistance	R _g	V _{DS} =0V, V _{GS} =1V at 1MHz	-	1	-	Ω
Forward Transconductance	g _{fs}	V _{DS} =10V, I _D =35A	-	6	-	S
Dynamic						
Total Gate Charge	Q _g	V _{DS} =15V, I _D =35A, V _{GS} =10V	-	18.4	-	nC
Gate-Source Charge	Q _{gs}		-	3.57	-	
Gate-Drain Charge	Q _{gd}		-	2.9	-	
Turn-On Delay Time	td(on)	V _{DD} =15V, R _L =15Ω, I _D =1A V _{GEN} =10V, R _G =24Ω	-	11.7	-	nS
Turn-On Rise Time	tr		-	3.87	-	
Turn-Off Delay Time	td(off)		-	32.13	-	
Turn-Off Fall Time	tf		-	5.4	-	
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V, f=1MHz	-	1176.3	-	pF
Output Capacitance	C _{oss}		-	268.43	-	
Reverse Transfer Capacitance	C _{rss}		-	142.67	-	
Source-Drain Diode						
Max. Diode Forward Current	I _S		-	-	35	A
Diode Forward Voltage	V _{SD}	I _S =20A, V _{GS} =0V	-	0.87	1.5	V

NOTE: Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



Characteristics Curve

Fig.1 Output Characteristic

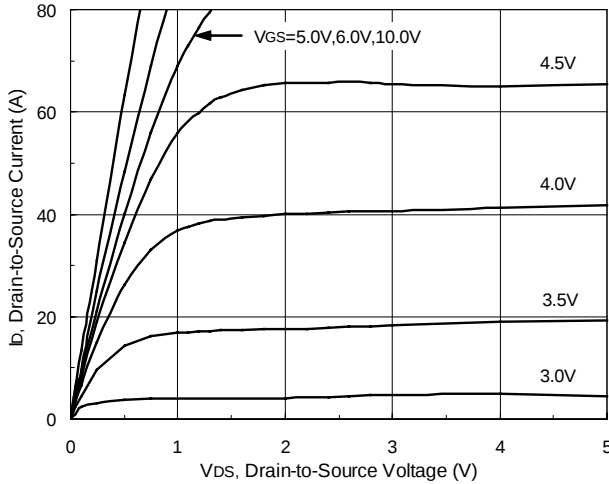


Fig.2 Transfer Characteristic

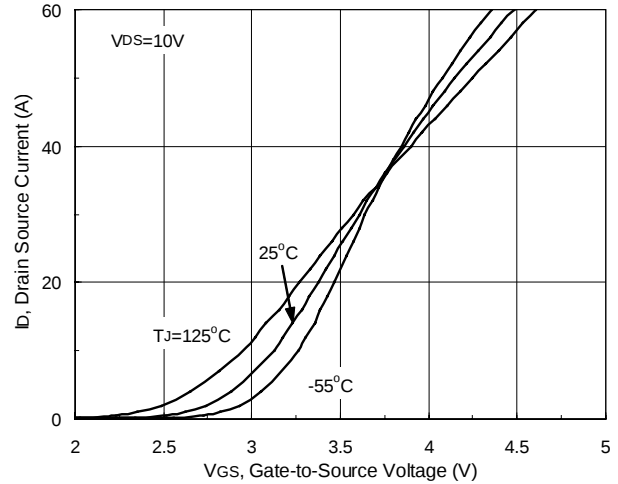


Fig.3 On Resistance & Drain Current

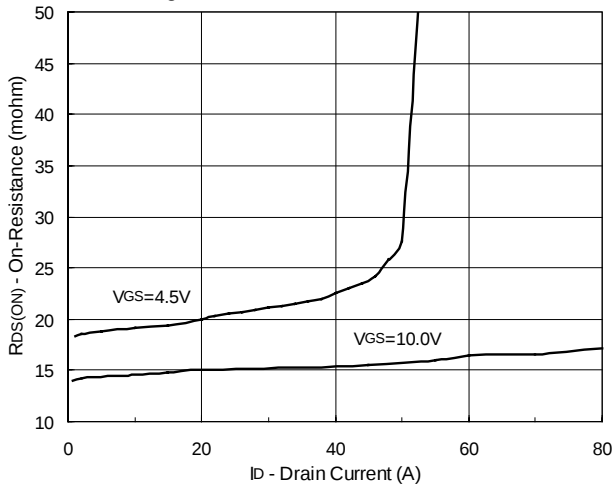


Fig.4 On Resistance & Gate to Source Voltage

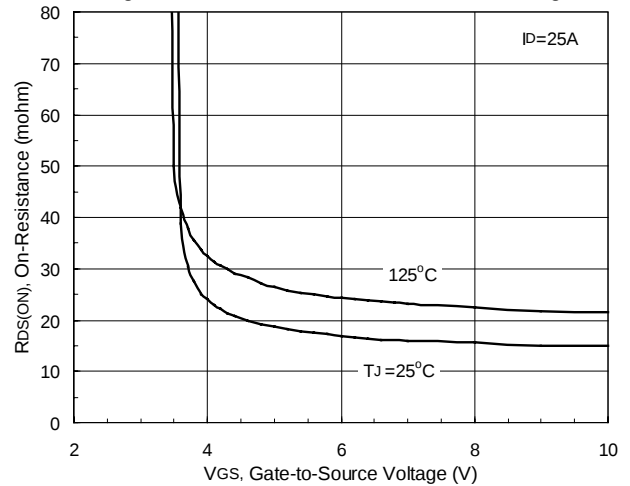


Fig.5 On Resistance & Junction Temperature

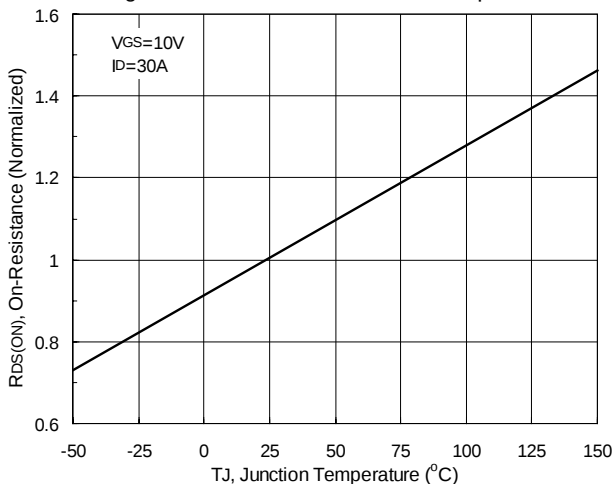
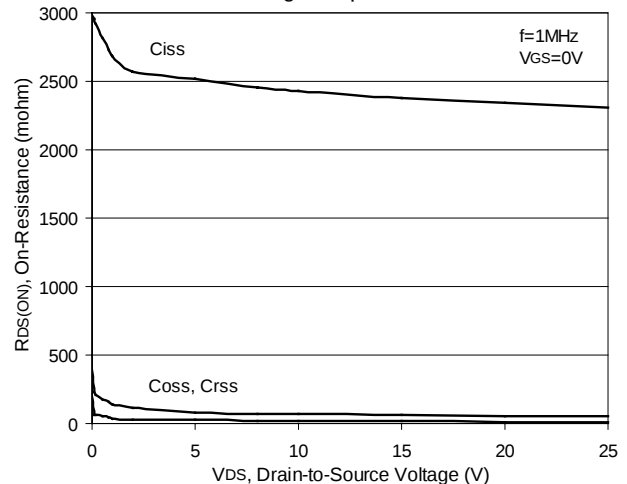
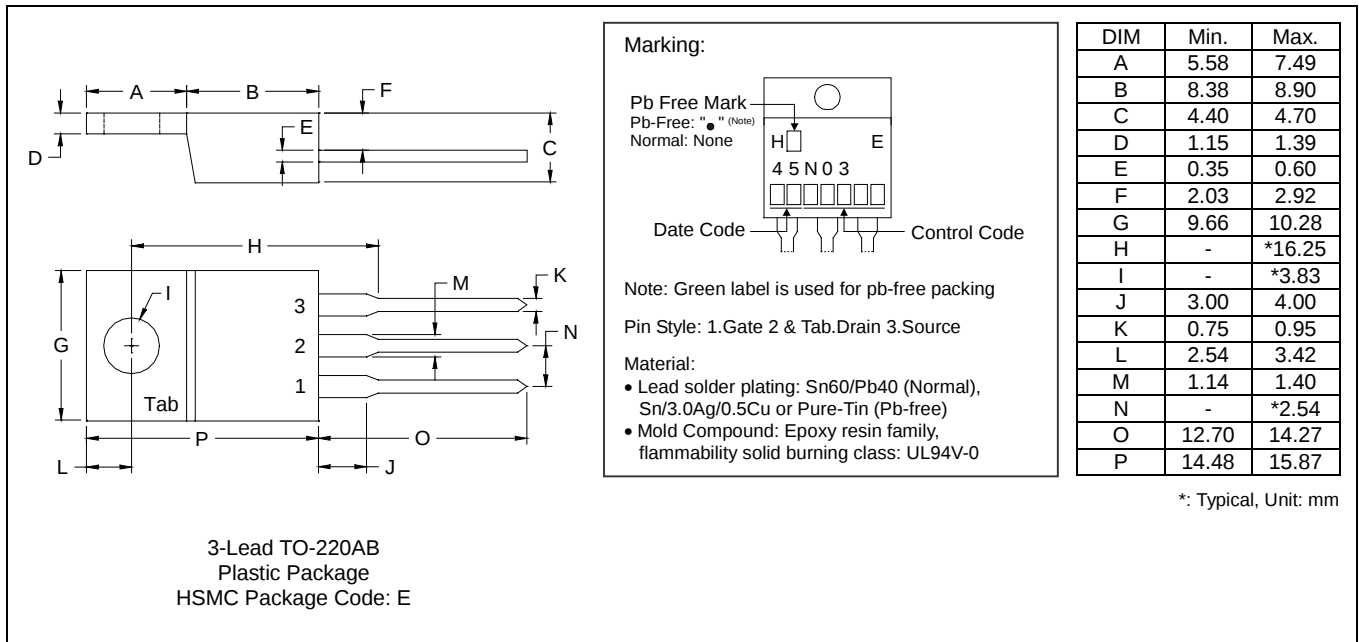


Fig.6 Capacitance





TO-220AB Dimension



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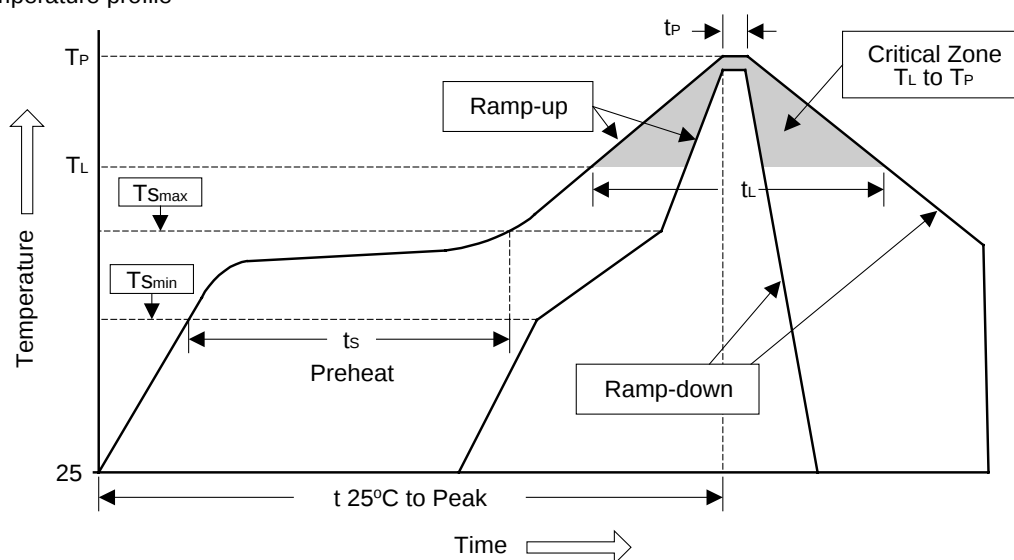
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Soldering Methods for HSMC's Products

1. Storage environment: Temperature=10°C~35°C Humidity=65%±15%
2. Reflow soldering of surface-mount devices

Figure 1: Temperature profile



Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T_L to T_P)	<3°C/sec	<3°C/sec
Preheat		
- Temperature Min (T_{Smin})	100°C	150°C
- Temperature Max (T_{Smax})	150°C	200°C
- Time (min to max) (t_s)	60~120 sec	60~180 sec
T_{Smax} to T_L		
- Ramp-up Rate	<3°C/sec	<3°C/sec
Time maintained above:		
- Temperature (T_L)	183°C	217°C
- Time (t_L)	60~150 sec	60~150 sec
Peak Temperature (T_P)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (t_P)	10~30 sec	20~40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25°C to Peak Temperature	<6 minutes	<8 minutes

3. Flow (wave) soldering (solder dipping)

Products	Peak temperature	Dipping time
Pb devices.	245°C ±5°C	5sec ±1sec
Pb-Free devices.	260°C +0/-5°C	5sec ±1sec